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# **Supporting Information**

## Insight into In-Plane Isotropic Transport in Anthracene-Based Organic Semiconductors

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### Contents

1.	Calculated Anisotropy Ratio and Related Parameters for Three Series of Anthracene Derivatives	S2
2.	The Molecular Packing Architecture Parameter $\theta$ and The Calculated Electronic Prop Parameter Vi for 2,6-ANTs, 9,10-ANTs, and 2-ANTs	perty S8
3.	Summary of Reported Mobility for Three Series of Anthracene Derivatives	S9
4.	Intermolecular Distance and Torsion Angle for 2,6-ANTs	S10
5.	Crystal Structure of BDBFAnt	S11
6.	Field Effect Mobility of BDBFAnt SC-OFETs by Considering Series Resistance	S12
7.	Theoretical Methodology in Details	S15
8.	References	S18

## 1. Calculated Anisotropy Ratio and Related Parameters for Three Series of Anthracene Derivatives

Table S1. Calculated anisotropy ratio and related parameters for 9,10-ANTs

#	Name	Structure	Packing	i	r <sub>i</sub> /Å	$\theta_i/^{\circ}$	γ <sub>i</sub> /°	V <sub>i</sub> (meV)	λ(eV)	$\mu_{max}/\mu_{min}$
				<b>P</b> <sub>1</sub>	8.628	0	38.2	1.01		
			$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	T <sub>1</sub>	9.136	42.1	0	4.54		
				84.7	42.3	3.76				
1	0.10 DDA nt		Slipped	T <sub>3</sub>	9.136	137.9	0	4.54	0.265	3.08
	9,10 <b>-</b> DPAIIt		Herringbone	P <sub>2</sub>	8.628	180.0	38.2	29.48	0.205	
				T <sub>4</sub>	9.136	222.1	0	4.54		
				T <sub>5</sub>	8.167	261.3	41.8	22.45		
				T <sub>6</sub>	9.136	317.9	0	4.54		
				<b>P</b> <sub>1</sub>	5.357	0	0	42.39	-	
				T <sub>1</sub>	13.299	54.6	69.7	4.96		
				T <sub>2</sub>	13.299	124.1	69.0	4.76		
2	DDEAnt		Slipped	T <sub>3</sub>	15.305	152.8	53.8	0.06	0.145	1.04~1.04
	DrEAIIt		Herringbone	P <sub>2</sub>	5.357	180.0	0	42.39	0.145	1.04^10*
				T <sub>4</sub>	10.018	227.3	38.0	0.7		
				T <sub>5</sub>	8.465	270.0	47.3	2.44		
				T <sub>6</sub>	10.018	313.3	38.8	0.7		

#	Name	Structure	Packing	i	r <sub>i</sub> /Å	$\theta_i/^{\circ}$	γ <sub>i</sub> /°	V <sub>i</sub> (meV)	λ(eV)	$\mu_{max}/\mu_{min}$	
	P <sub>1</sub> 5.95	5.957	0	0	13.77						
		~		T <sub>1</sub>	18.16	27.4	54.7	0.2			
				T <sub>2</sub>	16.088	54.4	71.4	0.06			
2			Slipped	T <sub>3</sub>	16.088	128.8	72.8	0.06	0.146	7.46	
3	BNEAN		Herringbone	Herringbone	P <sub>2</sub>	5.957	180.0	0	13.77	0.140	7.46
				T <sub>4</sub>	9.639	238.4	53.9	8.88			
				T <sub>5</sub>	9.639	278.8	52.7	8.87		7.46	
				T <sub>6</sub>	12.801	339.3	34.0	0.01	1		

#	Name	-R=	Packing	i	r₁/Å	$\theta_i/^{\circ}$	γi/°	V <sub>i</sub> (meV)	λ(eV)	$\mu_{max}/\mu_{min}$
				<b>P</b> <sub>1</sub>	6.019	0		10.3		
				T <sub>1</sub>	5.057	53.48		4.14	0.174	
1	No Ant	-R=	Layered	T <sub>2</sub>	5.057	126.52		4.15		20.4
4	INAAIIt		Herringbone	P <sub>2</sub>	6.019	180		10.3	0.1/4	20.4
				T <sub>3</sub>	5.117	233.97		5.33		
				T <sub>4</sub>	5.117	306.03		5.65		
				<b>P</b> <sub>1</sub>	5.957	0		27.04		
		R		T <sub>1</sub>	4.805	51.34		42.44		
5	2 Ant		Layered	T <sub>2</sub>	4.777	128.22		40.53	0.104	1.92
5	ZAIIt	-R=	Herringbone	<b>P</b> <sub>2</sub>	5.957	180		27.04	-	1.02
				T <sub>3</sub>	4.748	231.42		47.76		
				T <sub>4</sub>	4.777	308.66		35.50		
				<b>P</b> <sub>1</sub>	6.049	0	0	5.94		
		<b>D</b> -		<b>T</b> <sub>1</sub>	5.087	51.556	14.19	8.22		
6	ElAnt	-R=	Layered	T <sub>2</sub>	5.037	127.05	10.63	52.14	0.185	110.5
			Herringbone	P <sub>2</sub>	6.049	180	0	5.94	0.185	110.5
				T <sub>3</sub>	5.093	232.45	12.85	15.94		
				T <sub>4</sub>	5.093	308.28	16.55	5.54		

**Table S2**. Calculated anisotropy ratio and related parameters for 2-ANTs

#	Name	-R=	i	r <sub>i</sub> /Å	θ <sub>i</sub> /°	V <sub>i</sub> (meV)	λ(eV)	$\mu_{max}/\mu_{min}$	μ <sub>max</sub> /μ <sub>min</sub> (Experimental)
		ene R		6.01	0	40.40			
	Anthracene			5.22	54.9	23.23	0.138	9.55	
		R = -H	T <sub>2</sub>	5.22	125.1	23.23			
		R=	Р	6.09	0	9.65			
7a	DTAnt		T <sub>1</sub>	4.835	51.0	39.78	0.261	.261 1.50	
			T <sub>2</sub>	4.835	129.0	39.78			
	DHTAnt	R =	Р	5.866	0	20.61	0.313	1.09	
7b			T <sub>1</sub>	4.72	51.6	29.75			
			T <sub>2</sub>	4.72	128.4	29.75			
			1	5.888	0	36.3			
			2	4.695	51.5	52.07			
0.0	DDVA		3	4.718	128.9	57.42	0.166	1.12	15105
88	DrvAnt	R =	4	5.888	180.0	36.3	0.100	1.12	1.3-1.93
			5	4.718	231.1	57.42			
			6	4.695	308.5	52.07			

**Table S3**. Calculated anisotropy ratio and related parameters for 2-6-ANTs

#	Name	-R=	i	r <sub>i</sub> /Å	θ <sub>i</sub> /°	V <sub>i</sub> (meV)	λ(eV)	$\mu_{max}/\mu_{min}$	μ <sub>max</sub> /μ <sub>min</sub> (Experimental)
		R =	Р	5.848	0	32.08			
8b	DPPVAnt		T <sub>1</sub>	4.65	51.0	59.36	0.181	1.3	
			T <sub>2</sub>	4.65	129.0	59.36			
		D	Р	6.235	0	31.38			
9	o-DPyAnt	R = N =	T <sub>1</sub>	4.816	49.7	78.98	0.155	1.32	
			T <sub>2</sub>	4.816	130.3	78.91			
	DPA	$DPA \qquad R = - $	Р	6.245	0	10.01		1.38	
10			<b>T</b> <sub>1</sub>	4.823	49.6	56.97	0.176		1.3-1.5
			T <sub>2</sub>	4.823	130.4	56.97			
		D -	Р	6.04	0	20.53			
11	BEPAnt		T <sub>1</sub>	4.9	51.9	38.47	0.179	1.4	1.3-2.0
			T <sub>2</sub>	4.9	128.1	38.47			
		D -	Р	6.16	0	10.91			
12	BOPAnt	PAnt $R = - 0$	<b>T</b> <sub>1</sub>	4.83	50.4	33.74	0.249	1.49	1.2
			T <sub>2</sub>	4.83	129.6	33.74			

#	Name	-R=	i	r <sub>i</sub> /Å	θ <sub>i</sub> /°	V <sub>i</sub> (meV)	λ(eV)	$\mu_{max}/\mu_{min}$	μ <sub>max</sub> /μ <sub>min</sub> (Experimental)
		R =	Р	5.98	0	18.43			
13	BDBFAnt		T <sub>1</sub>	4.79	51.4	33.56	0.166	1.32	1.2-1.3
		0	T <sub>2</sub>	4.79	128.6	33.56			

\* Experimental results of single-crystal OFETs.

2. The Molecular Packing Architecture Parameter  $\theta_i$  and The Calculated Electronic Property Parameter  $V_i$  for 2,6-ANTs, 9,10-ANTs, and 2-ANTs



**Figure S1.** Layered-herringbone (LHB) packing with molecules arranged symmetrically with respect to a line along the parallel ( $\pi$ - $\pi$  stacking) direction satisfies  $r_{T1} \approx r_{T2}$ ,  $\theta_{T2} \approx \pi - \theta_{T1}$ . In this case, the molecular arrangement is symmetrical with respect to both directions parallel and perpendicular to the  $\pi$ - $\pi$  stacking direction. The dual symmetry results in equal transfer integrals, i.e.,  $V_{T1} \approx V_{T2}$ . 2,6-ANTs satisfy these conditions including the material #**8a**.



**Figure S2.** The molecular packing architecture parameter  $\theta_i$  and the calculated electronic property parameter  $V_i$  for (a)-(c) 9,10-ANTs and for (d)-(f) 2-ANTs.



## 3. Summary of Reported Mobility for Three Series of Anthracene Derivatives

**Figure S3**. Reported field-effect hole mobility for three series of anthracene derivatives. The data for 9,10-ANTs, 2-ANTs, and 2,6-ANTs are colored in blue, yellow, and red, respectively.

## 4. Intermolecular Distance and Torsion Angle for 2,6-ANTs



**Figure S4**. Intermolecular distances between the centroids of neighboring molecules in 2,6-ANTs for (a) datasets of blue dots and (b) those of black dots in **Figure 3**.

**Table S4**. List of torsion angles between the central anthracene ring and side group obtained from single-crystal data of 2,6-ANTs.

#	Name	Torsion Angle (°)
8b	DPPVAnt	2.13
8a	DPVAnt	3.26
7b	DHTAnt	5.54
7a	DTAnt	10.71
11	BEPAnt	11.38
12	BOPAnt	15.61
10	DPA	20.33
9	o-DPyAnt	28.52

# 5. Crystal Structure of BDBFAnt



Figure S5. Facet angles of BDBFAnt within the basal packing plain.

### 6. Field Effect Mobility of BDBFAnt SC-OFETs by Considering Series Resistance



Figure S6. Equivalent circuit of BDBFAnt SC-OFET by taking account of series resistances in source and drain sides,  $R_s$  and  $R_d$ , respectively. Formulas are derived under the assumption of  $R_s = R_d = R_{sd}$ .

**Table S5**. Summary of fitting results with and without considering series resistance  $R_{sd}$ . S is the total area of the source and drain contacts, d is the thickness of the single crystal,  $\rho$  is resistivity, and n is carrier concentration in the active layer at  $V_g = V_{th} - 10$  V, respectively.

							Consider	ing series res	sistance R <sub>sd</sub>		Without c	onsidering R <sub>sd</sub>
OFET No.	<i>W</i> (μm)	<i>L</i> (μm)	S (cm <sup>2</sup> )	d (cm)	Vg	Vth (V)	μ (cm <sup>-2</sup> V <sup>-1</sup> s <sup>-1</sup> )	$R_{\rm sd}$ (k $\Omega$ )	ρ (Ωcm)	n@V <sub>th</sub> - 10 (V) (cm <sup>-3</sup> )	Vth (V)	μ (cm <sup>-2</sup> V <sup>-1</sup> s <sup>-1</sup> )
1	260	42	6 1E 09	4 55 09	Forward	-38.3	2.7	20	4 15+04	5.7E+13	-38.3	2.5
1 2	200	42	0.1E-00	4.5⊏-08	Reverse	-42.8	3.3	30	4.12+04	4.6E+13	-42.8	2.7
2	202	42	E 2E 09	4 55 09	F	-37.8	2.5	120	1 45+05	1.8E+13	-37.8	2.0
2	202	42	5.5∟=00	4.5∟-00	R	-42.5	3.2	120	1.4E+05	1.4E+13	-42.5	2.3
2	205	20	4 05 00	-08 4.5E-08	F	-47.5	2.4	70	7 45 104	3.5E+13	-47.5	2.0
3	205	39	4.8E-08		R	-50.6	2.9	70	7.4⊑+04	2.9E+13	-50.6	2.3
4	170	40	4 05 00	4 55 00	F	-42.5	1.9	00	7 15 104	4.6E+13	-42.5	1.5
4	1/0	40	4.0E-00	4.5E-00	R	-47.9	2.6	80	7.1E+04	3.4E+13	-47.9	2.0
_	400	40	0.75.00	E-08 4.5E-08	F	-43.6	2.3	110	0.05.04	4.1E+13	-43.6	1.9
5	133	42	2.7E-08		R	-49.4	3.3	110	6.6E+04	2.9E+13	-49.4	2.5

a) Large crystal

### b) Small crystals

							Consideri	ng series res	istance R <sub>sd</sub>		Without co	onsidering R <sub>sd</sub>		
OFET No.	<i>W</i> (μm)	<i>L</i> (μm)	S (cm <sup>2</sup> )	d (cm)	Vg	Vth (V)	μ (cm <sup>-2</sup> V <sup>-1</sup> s <sup>-1</sup> )	$R_{\rm sd}$ (k $\Omega$ )	ρ (Ωcm)	n@V <sub>th</sub> - 10 (V) (cm <sup>-3</sup> )	Vth (V)	μ (cm <sup>-2</sup> V <sup>-1</sup> s <sup>-1</sup> )		
1	106	13	4 0E 08	6 0E 08	Forward	-37.3	2.6	320	2 1E±05	1.1E+13	-37.3	1.7		
I	190	40	4.02-00	0.02-00	Reverse	-40.3	2.8	520	2.1E+05	1.0E+13	-40.3	1.8		
	189	46	2 25 09	4.05.09	F	-26	2.5	200	2 15+05	1.2E+13	-26.0	1.7		
2			2.2L-00	4.02-00	R	-31.3	3.0	300	2.12.03	9.9E+12	-31.3	1.7		
2	204	20		4 55 09	F	-45.9	2.7	120	2 15+05	1.1E+13	-45.9	1.8		
3	304	29	0.0E-00	4.3E-00	R	-46.5	3.0	120	2.1E+05	9.8E+12	-46.5	1.9		
4	102	50	1 7E 00	08 5.3E-08		F 0F 00	F	-44.9	2.7	400	0.45.04	3.8E+13	-44.9	2.2
4	193	50	50 1.7E-08		R	-49.2	3.4	190	0.12+04	3.0E+13	-49.2	2.3		



(a)

**Figure S7.** (a) Micrograph of the fabricated fan-shaped SC-OFET device. Five SC-OFETs (#1 - #5) were obtained. (b), (d), (f), (h), (j) Transfer curve  $(I_d - V_g)$  for each SC-OFET #1 - #5, respectively. Transfer curves were obtained in the saturation region ( $V_d = -40$  V) after three consecutive measurements. (c), (e), (g), (i), (k) Output curve ( $I_d - V_d$ ) for each SC-OFET #1 - #5, respectively. Each  $I_d - V_d$  curve was taken before measuring transfer curve; we observed a transient response in measuring  $I_d - V_d$ , i.e., holes in the active layer were captured by interface traps between organic semiconductor and OTS-modified SiO<sub>2</sub> layer.



**Figure S8.** (a), (d), (g), (j) Micrographs of the fabricated SC-OFETs. Four SC-OFETs (#1' - #4') were shown. (b), (e), (h), (k) Transfer curve  $(I_d - V_g)$  for each SC-OFET #1' - #4', respectively. Transfer curves were obtained in the saturation region ( $V_d = -40$  V) after three consecutive measurements. (c), (f), (i), (l) Output curve ( $I_d - V_d$ ) for each SC-OFET #1' - #4', respectively. Each  $I_d - V_d$  curve was taken before measuring transfer curve; we observed a transient response in measuring  $I_d - V_d$ , i.e., holes in the active layer were captured by interface traps between organic semiconductor and OTS-modified SiO<sub>2</sub> layer.

#### 6. Theoretical Methodology in Details

A model combining Marcus-Hush theory with first-principle quantum mechanics is developed for the analysis in this work.<sup>14, 15</sup> The hopping events are considered as irrelevant from each other. Besides, homogeneous random walk is assumed for the charge motion between molecules. Thereby, the diffusion coefficient between molecules based on the hopping rate could be derived as

$$D = \lim_{t \to \infty} \frac{1 \langle x(t^2) \rangle}{2n - t} \approx \frac{1}{2n} \sum_{i} r_i^2 W_i P_i$$
(1)

where *n* is the spatial dimensionality of the system,  $r_i$  is the distance between two molecules,  $P_i$  is the relative probability of the charge transfer in *i*th dimer and  $W_i$  is the charge transfer rate of the *i*th dimer. Meantime,  $W_i$  calculated from Marcus-Hush equation can be obtained as follows,

$$W_{i} = \frac{V^{2}}{\hbar} \left( \frac{\pi}{\lambda k_{B} T} \right)^{\frac{1}{2}} \exp\left( -\frac{\lambda}{4k_{B} T} \right)_{.}$$
(2)

Here, V is the transfer integral between two neighboring molecules and  $\lambda$  is the reorganization energy,  $k_B$  is the Boltzmann constant, T is absolute temperature.

Hopping probability  $P_i$  is calculated from the following equation

$$P_i = \frac{W_i}{\Sigma W_i} \tag{3}$$

The hopping mobility ( $\mu$ ) is obtained from Einstein's equation as follows,

$$\mu = \frac{e}{k_B T} D = \frac{e}{k_B T 2n} \sum_i r_i^2 W_i P_i$$
(4)

where *e* is unit charge. In order to evaluate in-plane mobility anisotropy, a further derivation is necessary for equation (4). Wen *et al.* analyzed the mobility of components for each surface in terms of angles of the hopping jumps ( $\gamma_i$ ) between adjacent molecules relative to the plane of interest ( $Vr_i \cos \gamma_i$ ). According to their consideration, the transfer mobility ( $\mu(\varphi)$ ) can be obtained as follows,

$$\mu(\varphi) = \frac{e}{k_B T 2n} \sum_{i} [r_i \cos \gamma_i \cos \left(\theta_i - \varphi\right)]^2 W_i P_i = \sum_{i} \mu_i \cos^2 \gamma_i \cos^2 \left(\theta_i - \varphi\right),$$
(5)

where  $r_i \cos \gamma_i \cos (\theta_i - \varphi)$  is the projection of the hopping path on the transistor channel,  $\mu_i$  is the individual mobility on each charge hopping path,  $\gamma_i$  is the angle between the each charge hopping path and the plane of interest. **Figure 1**a schematically shows the hopping paths and angles for the herringbone packing monolayer. Three types of hopping paths including parallel (P), transverse type 1 (T1) and type 2 (T2) and the angles ( $\theta_{T1}$  and  $\theta_{T2}$ ) between P and T1(or T2) contacts are labelled. The orientation angle ( $\varphi$ ) of the transistor channel is defined as the base of b-axis (the parallel direction).

In order to analyze the carrier transport anisotropy of organic semiconductors, we need the maximum and the minimum of function  $\mu(\varphi)$ . In order to obtain these values, we simplify equation (5) to a lower order as follows,

$$\mu(\varphi) = \sum_{i} \frac{1}{2} \mu_i \cos^2 \gamma_i [1 + \cos \left(2\theta_i - 2\varphi\right)]$$
(6)

The equation could be further written as

$$u(\varphi) = A\cos 2\varphi + B\sin 2\varphi + C, \tag{7}$$

where factors A, B, and C are

$$A = \frac{1}{2} \sum_{i} \mu_{i} \cos^{2} \gamma_{i} \cos 2\theta_{i}$$
(8)

$$B = \frac{1}{2} \sum_{i} \mu_{i} \cos^{2} \gamma_{i} \sin 2\theta_{i}$$
, (9)

$$C = \frac{1}{2} \sum_{i} \mu_i \cos^2 \gamma_i \tag{10}$$

Thereby, the maximum and the minimum mobility for any types of organic semiconductors can be obtained as follows,

$$\mu_{max} = C + \sqrt{A^2 + B^2},$$
(11)

$$\mu_{min} = C - \sqrt{A^2 + B^2}$$
(12)

According to these equations, we can directly calculate the mobility anisotropy ratio  $({}^{\mu_{max}/\mu_{min}})$  using electronic property parameters (transfer integral V and reorganization energy  $\lambda$ ) and molecular packing architecture parameters (r,  $\theta$ , and  $\gamma$ ) for organic semiconductors.

Organic semiconductors such as 2,6-Ants have the herringbone packing motif with a symmetric arrangement with respect to a line along the parallel ( $\pi$ - $\pi$  stacking) direction and satisfy specific conditions, which are  $r_{T1} = r_{T2}$ ,  $\theta_{T2} = \pi - \theta_{T1}$  in **Figure 1**a, and  $V_{T1} = V_{T2}$ . Here,  $V_{T1}$  and  $V_{T2}$  are the transfer integrals between dimers along the T1 and T2 direction with hopping distances of  $r_{T1}$  and  $r_{T2}$ , respectively.  $\theta_{T1}$  and  $\theta_{T2}$  are the angles between P and T1 (or T2) directions, respectively. From geometry we can prove that  $r_{T1} = r_{T2}$  and  $\theta_{T2} = \pi - \theta_{T1}$  are equivalent, and they are true if the molecular arrangement is symmetrical with respect to both directions parallel and perpendicular to the  $\pi$ - $\pi$  stacking direction. We applied these conditions to calculate the anisotropy ratio. Under these conditions, hopping paths T1, T2, and P within a dimer are exactly on the same plane (the basal stacked layer), and then  $\gamma_i$  is 0°. Thereby, equivalent hopping paths T1 and T2 can be simplified as  $T_1$  and  $\pi$ - $\theta_T$ . (see **Figure S1**). In addition, we only consider the charge mobilities of  $\mu_P$  and  $\mu_T$  along the P and T directions, which could be derived from transfer integral of dimers and  $\theta_T$ ,

$$\frac{\mu_P}{\mu_T} = (V_P/V_T)^4 (r_P/r_T)^2 = (R)^4 (2\cos\theta_T)^2$$
(13)

where  $V_P$  and  $V_T$  are the transfer integrals between dimers along the P and T directions with hopping distances of  $r_P$  and  $r_T$ , respectively. R is the ratio of the transfer integrals of  $V_P$  and  $V_T$  ( $R \equiv V_P/V_T$ ).

Therefore, we can easily identify a specific condition for factor B being equal to zero, and then factors A, B, and C can be simplified as

$$A = \mu_T \left[ R^4 (2\cos\theta_T)^2 + 2\cos 2\theta_T \right], \tag{14}$$

$$B = 0, \tag{15}$$

$$C = \mu_T [R^4 (2\cos\theta_T)^2 + 2].$$
(16)

A function  $f(R, \theta_T)$  specific for in-depth analysis of the relationship between mobility anisotropy, transfer integral and the angle  $\theta_T$  is derived as following,

$$\frac{\mu_{max}}{\mu_{min}} = \frac{C + |A|}{C - |A|} = f(R, \theta_T) = \frac{2 + R^4 (2\cos\theta_T)^2 + |R^4 (2\cos\theta_T)^2 + 2\cos 2\theta_T|}{2 + R^4 (2\cos\theta_T)^2 - |R^4 (2\cos\theta_T)^2 + 2\cos 2\theta_T|}.$$
(17)

For calculation of the reorganization energy  $(\lambda)$ , adiabatic potential energy surfaces method was applied, which could be described with the following equation,

$$\lambda = (E_0^* - E_0) + (E_+^* - E_+)$$
(18)

where  $E_0$  and  $E_+$  represent the energies of the neutral and cationic species in their lowest-energy geometries, respectively;  $E_0^*$  is the energy of neutral state with the geometry of the cationic species, and  $E_+^*$  is the energy of the cationic state with the geometry of the neutral species. All geometric optimizations and energy evaluations in the process were conducted with Gaussian 09 using the B3LYP functional set and the 6-311G(d,p) basis set.

The transfer integral of each dimer  $(V_i)$  was calculated from the corresponding spatial overlap  $(S_{RP})$ , charge transfer integral  $(J_{RP})$ , site energies  $(H_{RR}, H_{RP})$  of the dimer,

$$V_{i} = \frac{J_{RP} - S_{RP} (H_{RR} + H_{RP})/2}{1 - S_{RP}^{2}}.$$

(19)

Calculations of the essential parameters ( $S_{RP}$ ,  $J_{RP}$ ,  $H_{RR}$ ,  $H_{RP}$ ) were performed using fragment analysis functions implemented in Amsterdam Density Function (ADF) software pack, which adopts PW91 functional and basis set of Double-Z 2 plus polarization function (DZ2P).

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